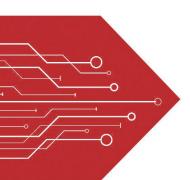
MSKSEMI















ESD

TVS

TSS

MOV

GDT

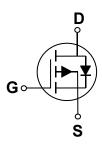
PLED

Brodnet data speet

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SOT-23



Features

- -20V,-4.3A, RDS(ON)=40mΩ@VGS=-4.5V
- Improved dv/dt capability
- Fast switching
- Green Device Available

Applications

- Notebook
- Load Switch
- Hend-Held Instruments

BVDSS	RDSON	ID
-12V	40m $Ω$	-4.3A

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	-12	V
V _G S	Gate-Source Voltage	±12	V
1_	Drain Current – Continuous (T _C =25°C)	-4.3	Α
I _D	Drain Current – Continuous (T _C =100°C)	-3	Α
I _{DM}	Drain Current – Pulsed ¹	-17.2	Α
D-	Power Dissipation (Tc=25°C)	1.56	W
P _D	Power Dissipation – Derate above 25°C	0.012	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		80	°C/W

Electrical Characteristics (T_J=25 , unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-12		-	V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.02		V/°C
,	Dunin Course Lookens Courset	V _{DS} =-20V , V _{GS} =0V , T _J =25°C			-1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =-16V , V _{GS} =0V , T _J =125°C			-10	uA
Igss	Gate-Source Leakage Current	V _{GS} =±12V , V _{DS} =0V			±100	nA

On Characteristics

R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-4.5V , I _D =-3A		40	55	mΩ	
Otatic Dialit-Source Off-Resistance		V _{GS} =-2.5V , I _D =-2A		55	85	11122	
V _{GS(th)}	Gate Threshold Voltage	V _G s=V _D s , I _D =-250uA		-0.6	-1.0	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			2		mV/°C	
gfs	Forward Transconductance	V _{DS} =-10V , I _S =-3A		7		S	

Dynamic and switching Characteristics

•					
Qg	Total Gate Charge ^{2, 3}			9.6	
Qgs	Gate-Source Charge ^{2, 3}	V _{DS} =-10V , V _{GS} =-4.5V , I _D =-3A		1.6	 nC
Q_{gd}	Gate-Drain Charge ^{2, 3}			2	
T _{d(on)}	Turn-On Delay Time ^{2, 3}			6	
Tr	Rise Time ^{2, 3}	V_{DD} =-10V , V_{GS} =-4.5V , R_{G} =25 Ω		21.6	 0
T _{d(off)}	Turn-Off Delay Time ^{2, 3}	I _D =-1A		51	 nS
Tf	Fall Time ^{2, 3}			13.8	
Ciss	Input Capacitance			850	
Coss	Output Capacitance	V _{DS} =-10V , V _{GS} =0V , F=1MHz		70	 pF
Crss	Reverse Transfer Capacitance			55	

Drain-Source Diode Characteristics and Maximum Ratings						
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	VVOV Force Current			-4.3	Α
I _{SM}	Pulsed Source Current	V _G =V _D =0V , Force Current			-8.6	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =-1A , T _J =25°C			-1.2	V

Note:

- Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 3. Essentially independent of operating temperature.



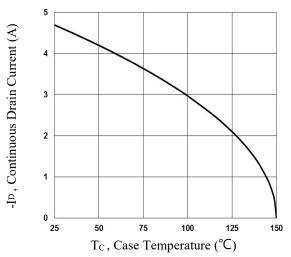


Fig.1 Continuous Drain Current vs. Tc

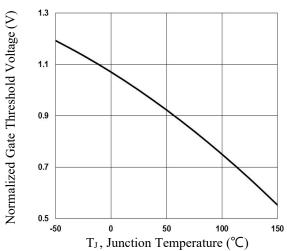


Fig.3 Normalized V_{th} vs. T_J

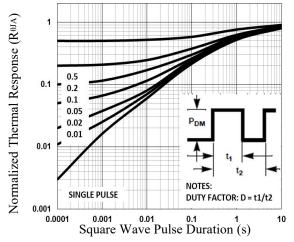


Fig.5 Normalized Transient Impedance

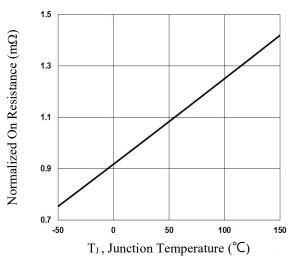


Fig.2 Normalized RDSON vs. T_J

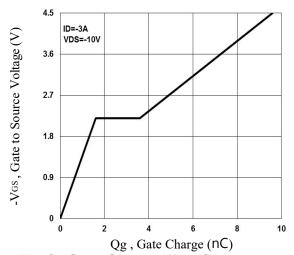


Fig.4 Gate Charge Waveform

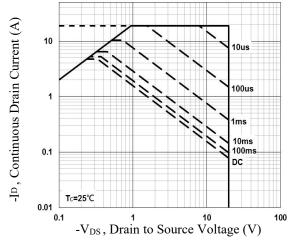
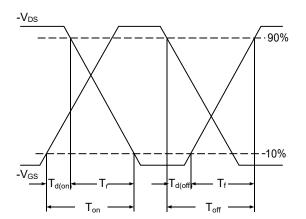


Fig.6 Maximum Safe Operation Area





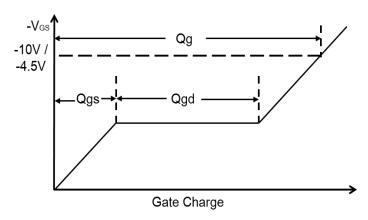
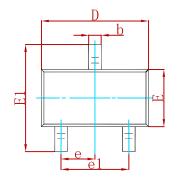
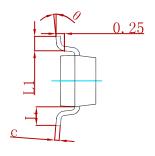


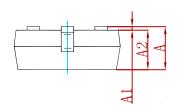
Fig.7 Switching Time Waveform

Fig.8 Gate Charge Waveform

PACKAGE MECHANICAL DATA

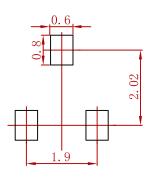






Symbol	Dimensions	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
Е	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950 TYP		0.037	7 TYP
e1	1.800	2.000	0.071	0.079
L	0.550 REF 0.022 REF		REF	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Suggested Pad Layout



- 1.Controlling dimension:in millimeters.2.General tolerance:± 0.05mm.3.The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
IRLML6401	SOT-23	3000



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